## Inference for Clustering and Anomaly Detection

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## How many clusters are "really" there?



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Popular answers: AIC, BIC, gap statistic (Tibshirani et al. (2001)), Hartigan index (Hartigan (1975)), the silhoutte statistic (Rousseeuw (1987)), Ghosh and Sen (1984), Milligan and Cooper (1985), Bock (1985), McLachlan and Peel (2000), Fraley and Raftery (2002), McLachlan and Peel (2004), McLachlan and Rathnayake (2014), ...

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## BIC Classes

- 1
- 2
- 3
- 4
- 5
- 6
- 7
- 8

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## Eg: The Cancer Genome Atlas (TCGA) project



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RNA sequence data: Head and neck squamous cell carcinoma (HNSC), lung squamous cell carcinoma (LUSC) and lung adenocarcinoma (LUAD). (Network et al. (2012), Network et al. (2014))

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## Sections of the talk

## 1. Clustering

How can we perform clustering that results in statistically significant clusters?

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In high energy physics, how can we detect new signals in experimental data in a model-independent way?

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## Gaussian Mixture

Clustering Using Relative Tests of Fit

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Joint work with:
Sivaraman Balakrishnan and
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## 2. Anomaly Detection

Model-Independent Detection of New Physics Signals Using Interpretable Semi-Supervised Classifier Tests

Joint work with:
Mikael Kuusela and Larry Wasserman

## Significant Clustering via SigClust: How it works! Proposed by Liu, Hayes, Nobel and Marron (2008) (Liu et al., 2008)

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$H_{0}: X_{1}, \ldots, X_{n} \sim N(\mu, \Sigma)$ versus
$H_{1}: X_{1}, \ldots, X_{n} \sim f(\cdot)$, which is a non-Gaussian distribution.

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\end{aligned}
$$

(2) Uses 2-means clustering and the Cluster Index for the test statistic.

$$
C I=\frac{\sum_{k=1}^{2} \sum_{j \in C_{k}}\left\|X_{j}-\bar{X}^{k}\right\|^{2}}{\sum_{j=1}^{n}\left\|X_{j}-\bar{X}\right\|^{2}}
$$

$C_{k}: k^{\text {th }}$ cluster and $\bar{X}^{k}: k^{\text {th }}$ cluster mean.

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$C_{k}: k^{\text {th }}$ cluster and $\bar{X}^{k}: k^{\text {th }}$ cluster mean.
(3) Computes the distribution of the Cl under $\mathrm{H}_{0}$ and the p-value.
(9) Works well in HDLSS data.

## Power of SigClust: Low power in some cases

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Theorem 1 (Chakravarti, Purvasha et al. (2019))
$X_{1}, \ldots, X_{n} \sim \frac{1}{2} N(-\mu, \Sigma)+\frac{1}{2} N(\mu, \Sigma), \mu=\left(\frac{2}{2}, 0, \ldots, 0\right)$,

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- if $\sigma_{2}^{2}>\frac{\pi}{2} \mathbb{E}\left[X_{i 1} \mid X_{i 1}>0\right]^{2}$, then $\lim _{n \rightarrow \infty} \operatorname{Power}_{n}(a)<1$,
$\frac{\pi}{2} \mathbb{E}\left[X_{i 1} \mid X_{i 1}>0\right]^{2} \approx \sigma_{1}^{2}+\frac{a^{2}}{4}$ for small a.


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& \sigma_{1}^{2}, \sigma_{2}^{2}>\sigma_{3}^{2} \geq \ldots \geq \sigma_{d}^{2} \text {. Under some symmetry assumptions, } \\
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$$



k-means optimal split, splits horizontally!

## Proposed test: Relative Information Fit Test (RIFT)

1. Gaussian Mixture Models: If $Y \in \mathbb{R}^{d} \sim p$ and $p_{k}$ is the density of $N\left(\mu_{k}, \Sigma_{k}\right)$, then for $\mathbf{y} \in \mathbb{R}^{d}$,

$$
p(\mathbf{y} \mid \pi, \mu, \Sigma)=\sum_{k=1}^{K} \pi_{k} p_{k}\left(\mathbf{y} \mid \mu_{k}, \Sigma_{k}\right)
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where $\pi_{k}$ are the mixing proportions $\left(0<\pi_{k}<1, \sum_{k} \pi_{k}=1\right)$.

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where $\pi_{k}$ are the mixing proportions ( $0<\pi_{k}<1, \sum_{k} \pi_{k}=1$ ).
2. Test if a mixture of two Gaussians fits the data significantly better than a single Gaussian.

## Proposed test: Relative Information Fit Test (RIFT)

Randomly split data into $D_{1}$ (Estimating) and $D_{2}$ (Testing).


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Using $D_{1}$, fit a Normal $\hat{p}_{1}$ and a mixture of two Normals $\hat{p}_{2}$.


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## Proposed test: Relative Information Fit Test (RIFT)

$\Gamma=K\left(p, \hat{\rho}_{1}\right)-K\left(p, \hat{p}_{2}\right)$, where $K$ is the KL distance, $p$ is the true density.


We test, conditioned on $D_{1}, H_{0}: \Gamma \leq 0$ versus $H_{1}: \Gamma>0$.

## Proposed test: Relative Information Fit Test (RIFT)

$\hat{p}_{1}, \hat{p}_{2}$
D1


$$
\hat{\Gamma}=\frac{1}{n} \sum_{i \in D_{2}} R_{i}, R_{i}=\log \left(\frac{\hat{p}_{2}\left(X_{i}\right)}{\hat{\rho}_{1}\left(X_{i}\right)}\right)
$$

D2


We test, conditioned on $D_{1}, H_{0}: \Gamma \leq 0$ versus $H_{1}: \Gamma>0$.
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## Proposed test: Relative Information Fit Test (RIFT)

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We test, conditioned on $D_{1}, H_{0}: \Gamma \leq 0$ versus $H_{1}: \Gamma>0$.

$$
\sqrt{n}(\hat{\Gamma}-\Gamma) / \tau \rightsquigarrow N(0,1) \Longrightarrow \text { Reject } H_{0} \text { if } \hat{\Gamma}>\frac{z_{\alpha} \hat{\tau}}{\sqrt{n}} \text {. }
$$

## Power of RIFT converges to 1 !

Power converges to 1 !
$\mathcal{P}_{1}$ : Normals, $\mathcal{P}_{2}$ : mixtures of two Normals.
Lemma 2
Suppose that $p \in \mathcal{P}_{2}-\mathcal{P}_{1}$. Then $P\left(\hat{\Gamma}>z_{\alpha} \hat{\tau} / \sqrt{n}\right) \rightarrow 1$ as $n \rightarrow \infty$.

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RIFT can be applied both hierarchically and sequentially to detect more than two clusters with asymptotic error control!

RIFT also has a more robust version - Median RIFT (M-RIFT)!

## Comparisions for 2 Normals: SigClust performs better

$$
X_{1}, \ldots, X_{n} \sim \frac{1}{2} N\left(\mu, I_{d}\right)+\frac{1}{2} N\left(-\mu, I_{d}\right) \text { where } \mu=(a, 0, \ldots, 0)
$$

Example where SigClust's power converges to 1 as $n \rightarrow \infty$.

Comparing Clustering Techniques with n varying


Method

- RIFT
- M-RIFT
- SigClust
- Mardia's Kurtosis
- Zhou's NN
— Zhou's NN (KS)


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- HDLSS - SigClust performs better.
- In a hierarchical setting, RIFTs perform better.


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## 1. Clustering

## Gaussian Mixture

Clustering Using Relative Tests of Fit

Joint work with:
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## 2. Anomaly Detection

Model-Independent Detection of New Physics Signals Using Semi-Supervised Classifier

## Tests

Joint work with:
Mikael Kuusela and Larry Wasserman

## CERN and the Large Hadron Collider



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The ATLAS and the CMS experiments at the LHC

CMS experiment


## ATLAS experiment



## Events from the experiments



## The Standard Model of particle physics



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## Experimental data

Experimental data are generated from one of the two processes:
Background - refers to the known physics (SM).
Signal - represents an unknown possible particle or interaction not accounted for in the SM.

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q=(1-\lambda) p_{b}+\lambda p_{s}, \quad \text { No signal: } \lambda=0
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## Model-dependent supervised methods

Two sources of data are at hand:

- Background + signal (Monte Carlo) sample - labelled observations

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Test $H_{0}: \lambda=0$ vs $H_{1}: 0<\lambda<1$.
Train a classifier (h) to separate signal from background.

## Model-dependent likelihood ratio using supervised classifier

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- Likelihood Ratio on the $W_{i}$ 's for $H_{0}: \lambda=0$ vs $H_{1}: 0<\lambda<1$ :

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\frac{\mathcal{L}_{q}(\lambda)}{\mathcal{L}_{q}(0)}=\prod_{i}\left[(1-\lambda)+\lambda \psi\left(W_{i}\right)\right], \quad \psi=p_{s} / p_{b}
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- The membership probabilities $h$ can be written as:

$$
h(z)=\widehat{\mathbb{P}}(Z \text { is signal } \mid Z=z)=\frac{n p_{s}(z)}{n p_{s}(z)+m p_{b}(z)}=\frac{n \psi(z)}{n \psi(z)+m} .
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- We can estimate

$$
\widehat{\psi}(z)=\frac{m h(z)}{n(1-h(z))} .
$$

## Model-dependent supervised methods test statistics

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(1) Likelihood Ratio Test Statistic:

$$
\mathrm{LRT}=2 \sum_{i} \log \left(\left(1-\hat{\lambda}_{\mathrm{MLE}}\right)+\hat{\lambda}_{\mathrm{MLE}} \hat{\psi}\left(W_{i}\right)\right)
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- Asymptotic method for first, permutation and bootstrap methods for both.


## Motivation for model-independent methods

- What if none of the current proposed models are right for the New Physics (NP) signals?
- How to look for NP when one is not totally sure what to look for?


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- What if none of the current proposed models are right for the New Physics (NP) signals?
- How to look for NP when one is not totally sure what to look for?

Classifier decision boundary

Actual NP signal


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## Solution: Model-independent methods

Two sources of data are at hand:

- Background (Monte Carlo) sample - labelled observations

$$
\text { Background: } \quad X_{1}, \ldots, X_{m} \sim p_{b}
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- Background + possible signal (experimental) sample - unlabelled observations

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Kuusela et al. (2012) and Vatanen et al. (2012) use Gaussian Mixture Models.

We use a classifier to detect the signal through rigorous inference.

## Proposed model-independent semi-supervised methods

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Train a classifier $(\tilde{h})$ to separate experimental from background.

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\text { Experimental: } \quad W_{1}, \ldots, W_{N} \sim q=(1-\lambda) p_{b}+\lambda p_{s}
$$

Train a classifier ( $\tilde{h}$ ) to separate experimental from background.
Note:

1. We don't use labelled signal observations.
2. We used Random Forest as a classifier.

## Proposed test statistics

- Likelihood Ratio on the $W_{i}$ 's for $H_{0}: \lambda=0$ vs $H_{1}: 0<\lambda<1$ :

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$$

- Classifier $\tilde{h}$ that separates experimental from background, gives $\widehat{\tilde{\psi}}(z)$.


## Proposed test statistics

- Likelihood Ratio on the $W_{i}$ 's for $H_{0}: \lambda=0$ vs $H_{1}: 0<\lambda<1$ :

$$
\frac{\mathcal{L}_{q}(\lambda)}{\mathcal{L}_{q}(0)}=\prod_{i} \tilde{\psi}\left(W_{i}\right), \quad \tilde{\psi}=q / p_{b}
$$

- Classifier $\tilde{h}$ that separates experimental from background, gives $\widehat{\tilde{\psi}}(z)$.
(1) Likelihood Ratio Test Statistic:

$$
\mathrm{LRT}=2 \sum_{i} \log \widehat{\tilde{\psi}}\left(W_{i}\right)
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- Asymptotic, permutation and bootstrap methods for both.

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## Kaggle's Higgs boson challenge

- Data provided by ATLAS.


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- 24, 645 background events and 25,734 signal events.
- Create experimental data in 100 simulations with varying signal strength, $\lambda$.
- Compare power of the methods in detecting the Higgs boson.


## Power - simulations where the Higgs boson is detected

$\lambda$ is the proportion of signal in the experimental data set.
100 simulations.

Model-dependent methods that have signal labels.

|  | Model | Method | Signal Strength ( $\lambda$ ) |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | 0.15 | 0.1 | 0.07 | 0.05 | 0.01 | 0 |
| $\stackrel{\square}{0}$ | Supervised LRT | Asymptotic | 99 | 70 | 22 | 5 | 0 | 0 |
| $\stackrel{\square}{\square}$ |  | Permutation | 99 | 93 | 59 | 19 | 1 | 0 |
|  | Supervised Score | Permutation | 99 | 94 | 80 | 51 | 13 | 7 |

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Power - simulations where the Higgs boson is detected $\lambda$ is the proportion of signal in the experimental data set.

100 simulations.


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## Density of the training data variables, $\lambda=0.15$



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## Identifying the active subspace that explains the classifier

- Consider $\nabla_{\mathbf{z}} \tilde{h}(\mathbf{z})$.


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- Perform Principal Component Analysis (PCA) or sparse PCA on $\nabla_{\mathbf{z}} \tilde{h}(\mathbf{z})$.
- Let $\mathbf{m}_{1}, \mathbf{m}_{2}, \ldots$ be the leading eigenvectors.
- Then $\mathbb{E}\left[\nabla_{\mathbf{z}} \tilde{h}\right], \mathbf{m}_{1}, \mathbf{m}_{2}, \ldots$ best captures the variation in the classifier $\tilde{h}$ (Constantine, 2015).


## Active subspace of $\tilde{h}(\cdot)$

For experimental data $W_{1}, \ldots, W_{N}$,

- $\nabla_{\mathbf{z}} h(\mathbf{z})-\nabla_{\mathbf{z}} h_{j}=\widehat{\nabla_{\mathbf{z}} \tilde{h}\left(W_{j}\right)}$ using a local linear smoother on $\tilde{h}$.


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- $\mathbb{E}\left[\nabla_{\mathbf{z}} \tilde{h}\right], \mathbf{m}_{1}, \mathbf{m}_{2}, \ldots-\overline{\nabla_{\mathbf{z}} h_{j}}=\frac{1}{N} \sum_{j=1}^{N} \nabla_{\mathbf{z}} h_{j}, \hat{\mathbf{m}}_{1}, \hat{\mathbf{m}}_{2}, \ldots$.


## Active subspace for $\tilde{h}(\cdot)$ when $\lambda=0.15$


First Eigenvector
( $\mathbf{m}_{1}$ )



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## Active subspace for $\tilde{h}(\cdot)$ when $\lambda=0.15$

The vectors capture the variable dependencies that influence the classifier.



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## Overview of Contributions

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## Thank you CMU Statistics \& Data Science and commitee members!



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## Future Work

- High-dimensional Clustering.

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- Relative Fit Methods. Compare different distance measures when comparing fits of densities.
- Interdisciplinary Collaborations.


## TCGA project: Multi-Cancer Gene Expression Dataset

- RNA sequence data from 3 types of cancer (Network et al. (2012), Network et al. (2014)).
- Head and neck squamous cell carcinoma (HNSC), lung squamous cell carcinoma (LUSC) and lung adenocarcinoma (LUAD).
- 300 samples: 100 from each of HNSC, LUSC and LUAD.



## TCGA project: Multi-Cancer Gene Expression Dataset

(1) RIFTs: 3 clusters.
(2) SigClust: 9 clusters.
(3) AIC: $12, \mathrm{BIC}: 8$.


## Asymptotic normality of $\hat{\Gamma}$

- Let $\hat{p}_{1}=N\left(\hat{\mu}_{0}, \hat{\Sigma}_{0}\right)$ and $\hat{p}_{2}=\hat{\alpha} N\left(\hat{\mu}_{1}, \hat{\Sigma}_{1}\right)+(1-\hat{\alpha}) N\left(\hat{\mu}_{2}, \hat{\Sigma}_{2}\right)$.


## Theorem 3

Assume each $\hat{\mu}_{i} \in \mathcal{A}$, a compact set and the eigenvalues of $\hat{\Sigma}_{i} \in\left[c_{1}, c_{2}\right]$. Let $Z \sim N\left(0, \tau^{2}\right)$ where $\tau^{2}=\mathbb{E}\left[\left(\tilde{R}_{i}-\Gamma\right)^{2} \mid \mathcal{D}_{1}\right]$. Then, under $H_{0}$

$$
\begin{equation*}
\sup _{t}\left|P\left(\sqrt{n}(\hat{\Gamma}-\Gamma) \leq t \mid \mathcal{D}_{1}\right)-P(Z \leq t)\right| \leq \frac{C}{\sqrt{n}} \tag{1}
\end{equation*}
$$

where $C$ is a constant that does not depend on $\mathcal{D}_{1}$.

## Median RIFT (M-RIFT): A more robust test.

- $\Gamma=\mathbb{E}_{p}[R]$, where $R=\log \hat{p}_{2}(X) / \hat{p}_{1}(X)$.
- Robustified version: $\tilde{\Gamma}=\operatorname{Median}_{p}[R]$, where $R=\log \hat{p}_{2}(X) / \hat{p}_{1}(X)$.
- Sample median of $R_{1}, \ldots, R_{n}$ is a consistent estimator, where $R_{i}=\log \hat{p}_{2}\left(X_{i}\right) / \hat{p}_{1}\left(X_{i}\right)$.
- Test $H_{0}: \tilde{\Gamma} \leq 0$ versus $H_{1}: \tilde{\Gamma}>0$ using the sign test.
- Replace KL distance with its median version. Gives an exact test


## 4 Normals: Hierarchical SigClust and RIFT

- $X_{1}, \ldots, X_{n} \sim 4$ Normals at vertices of a regular tetrahedron with side $\delta=5$ in $\mathbb{R}^{3} .50$ samples from each. 100 simulations. $\alpha=0.05$.


Hierarchical RIFT has Type I error control but hierarchical SigClust does

## Sequential RIFT (S-RIFT)

- Using $\mathcal{D}_{1}$, fit a mixture of $k$ Normals for $k=1,2, \ldots, K_{n}, K_{n}=\sqrt{n}$ (say).
- Using $\mathcal{D}_{2}$, for $j=1,2, \ldots$, we test

$$
\begin{gathered}
H_{0 j}:=K\left(p, \hat{p}_{j}\right)-K\left(p, \hat{p}_{s}\right) \leq 0 \quad \text { for all } s>j \text { versus } \\
H_{1 j}:=K\left(p, \hat{p}_{j}\right)-K\left(p, \hat{p}_{s}\right)>0 \quad \text { for some } s>j .
\end{gathered}
$$

- Reject $H_{0 j}$ if

$$
\max _{s} \hat{\Gamma}_{j s}>\frac{z_{\alpha / m_{j}} \hat{\tau}_{j s}}{\sqrt{n}}
$$

$m_{j}=K_{n}-j, \hat{\Gamma}_{j s}=\frac{1}{n} \sum_{i \in \mathcal{D}_{2}} R_{i}, R_{i}=\log \left(\frac{\hat{p}_{s}\left(X_{i}\right)}{\hat{p}_{j}\left(X_{i}\right)}\right)$ and $\hat{\tau}_{j s}^{2}=\frac{1}{n} \sum_{i \in \mathcal{D}_{2}}\left(R_{i}-\bar{R}\right)^{2}$.

- $\hat{k}$ is the first value of $j$ for which $H_{0 j}$ is not rejected. $\hat{p}_{\hat{k}}$ defines the clusters.


## Validity of S-RIFT

Unlike AIC or BIC, provides a valid, asymptotic, type I error control.

Lemma 4
Under $\mathrm{H}_{0}$,

$$
\limsup _{n \rightarrow \infty} P\left(\text { rejecting } H_{0 j}\right) \leq \alpha
$$

Note: Can be used with $L_{2}$ distance or Median version of KL distance.

## 4 Normals: Comparing S-RIFT to AIC and BIC

- $X_{1}, \ldots, X_{n} \sim 4$ Normals at vertices of a regular tetrahedron with side $\delta=6$ in $\mathbb{R}^{10}$.
- 100 samples from each. 100 simulations. $\alpha=0.05$.


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## Model-independent Method using Gaussian Mixture Models (GMMs)

Two sources of data are at hand:

- Background (Monte Carlo) sample - labelled observations

$$
X_{1}, \ldots, X_{m} \sim p_{b}
$$

- Background + possible signal (experimental) sample - unlabelled observations

$$
\begin{array}{r}
W_{1}, \ldots, W_{N} \sim q=(1-\lambda) p_{b}+\lambda p_{s} . \\
q\left(w \mid \theta_{s b}\right)=(1-\lambda) p_{b}\left(w \mid \theta_{b}\right)+\lambda p_{s}\left(\mathbf{y} \mid \theta_{s}\right),
\end{array}
$$

where $\theta_{s b}=\left(\theta_{s}, \theta_{b}, \lambda\right)$ and both the distribution of the anomaly $p_{s}$ and the distribution of the background $p_{b}$ are modeled by mixtures of Gaussian components.

Test for $H_{0}: \lambda=0$ versus $H_{1}: \lambda>0$ using likelihood catiqe destrellon University

## Confidence Intervals for AUC

- Newcombe's Wald Method (Newcombe, 2006) gives

$$
\widehat{V(\hat{\theta})}=\frac{\hat{\theta}(1-\hat{\theta})}{(n-1)(m-1)}\left[2 M-1-\frac{3 M-3}{(2-\hat{\theta})(1+\hat{\theta})}\right]
$$

where $M=\frac{n+m}{2}$.

- $100(1-\alpha) \%$ confidence interval for AUC $\theta$ is given by

$$
\hat{\theta} \pm z_{\alpha / 2} \sqrt{\widehat{V(\hat{\theta})}}
$$

where $z_{\alpha / 2}$ is the upper $\alpha / 2$ percentile of $\mathrm{N}(0,1)$.

- Test by rejecting $H_{0}: \theta=0.5$ if 0.5 is not in the $100(1-\alpha) \% \mathrm{Cl}$.


## Density of the variables



sublead_eta
0.15 -
0.10 -
0.00 -











class

| $\square$ |
| :--- |
| background |
| signal |

## Hierarchical RIFT (H-RIFT)

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## Hierarchical RIFT (H-RIFT) vs Sequential RIFT (S-RIFT)

$\hat{p}_{1}$ vs $\hat{p}_{2}$


## Hierarchical RIFT (H-RIFT) vs Sequential RIFT (S-RIFT)

$$
\hat{p}_{1} \text { vs } \hat{p}_{2}, \hat{p}_{3}, \ldots, \hat{p}_{K_{n}}
$$


$\hat{p}_{1}$ vs $\hat{p}_{2}$


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$$
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$$

$\hat{p}_{1}$ vs $\hat{p}_{2}$



$$
\hat{p}_{2} \text { vs } \hat{p}_{3}, \hat{p}_{4}, \ldots, \hat{p}_{K_{n}}
$$



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$$
\hat{p}_{1} \text { vs } \hat{p}_{2}, \hat{p}_{3}, \ldots, \hat{p}_{K_{n}}
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$\hat{p}_{1}$ vs $\hat{p}_{2}$


$\hat{p}_{2}$ vs $\hat{p}_{3}, \hat{p}_{4}, \ldots, \hat{p}_{K_{n}}$


$$
\hat{p}_{3} \text { vs } \hat{p}_{4}, \ldots, \hat{p}_{K_{n}}
$$



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